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Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			LLC DEDARATEMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL NO.			
			PATENT AND TRA	264054US2PCT	New U.S. PCT Application Based on PCT/JP02/08362					
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A	SM	AK	10-065470	03/06/98	JP (with English abstract & equivalent of 5917372)	f US			NO	
1		AL	04-117011	04/17/92	JP (with English abstract)				NO	
		АМ	2001-332984	11/30/01	P (with English abstract)				NO	
		AN	04-351005	12/04/92	JP (with English abstract)				NO	
		AO	98 10514	03/12/98	WO (with English abstract & equivalent 6167244)	/O (with English abstract & equivalent of US 167244)			NO	
		AP	05-198090	08/06/93	JP (with English abstract)				NO	
		AQ	09-018260	01/17/97	JP (with English abstract)				NO	
		AR	10-247856	09/14/98	JP (with English abstract & equivalent of 5930693)	of US			NO	
		AS	11-289231	10/19/99	JP (with English abstract)				·NO	
		AT	2001-168662	06/22/01	JP (with English abstract)				NO	
V		AU_	11-088083	03/30/99	JP (with English abstract)				NO	
A	SM	AV	2001-086179	03/30/01	JP (with English abstract)				NO	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)										
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